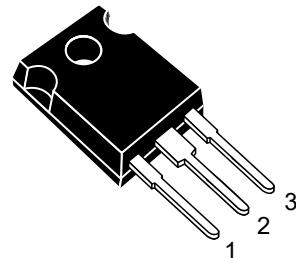


Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Resistant to Latch-Up
- Halogen Free, RoHS Compliant

V_{DS}	%\$V
I_{D(Tc=25°C)}	55A
R_{DS(on)}	40mΩ

Package TO-247-3L



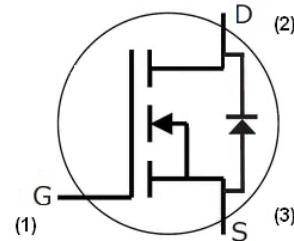
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC converters
- Battery Chargers
- Motor Drives
- Pulsed Power Applications

Equivalent Circuit



Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V _{DSmax}	Drain - Source Voltage	1200	V	V _{GS} = 0 V, I _D = 100 μA	
V _{GSm}	Gate - Source Voltage	-10/+25	V	Absolute maximum values	
V _{GSop}	Gate - Source Voltage	-5/+20	V	Recommended operational values	
I _D	Continuous Drain Current	55	A	V _{GS} = 20 V, T _C = 25°C	Fig. 19
		36		V _{GS} = 20 V, T _C = 100°C	
I _{D(pulse)}	Pulsed Drain Current	160	A	Pulse width t _P limited by T _{jmax}	Fig. 22
P _D	Power Dissipation	278	W	T _c =25°C, T _j = 150 °C	Fig. 20
T _J , T _{stg}	Operating Junction and Storage Temperature	-55 to +150	°C		
T _L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
M _d	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	

Electrical Characteristics (T_C = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			V	V _{GS} = 0 V, I _D = 100 μA	
V _{GS(th)}	Gate Threshold Voltage	2.0	3.2	4	V	V _{DS} = V _{GS} , I _D = 10mA	Fig. 11
			2.4		V	V _{DS} = V _{GS} , I _D = 10mA, T _J = 150 °C	
I _{DSS}	Zero Gate Voltage Drain Current		1	100	μA	V _{DS} = 1200 V, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current			250	nA	V _{GS} = 20 V, V _{DS} = 0 V	
R _{DS(on)}	Drain-Source On-State Resistance		44	52	mΩ	V _{GS} = 20 V, I _D = 40 A	Fig. 4,5,6
			82			V _{GS} = 20 V, I _D = 40 A, T _J = 150 °C	
g _{fs}	Transconductance		18.2		S	V _{DS} = 20 V, I _{DS} = 40 A	Fig. 7
			17.2			V _{DS} = 20 V, I _{DS} = 40 A, T _J = 150 °C	
C _{iss}	Input Capacitance		2440		pF	V _{GS} = 0 V V _{DS} = 1000 V f = 1 MHz V _{AC} = 25 mV	Fig. 17,18
C _{oss}	Output Capacitance		171				
C _{rss}	Reverse Transfer Capacitance		11				
E _{oss}	C _{oss} Stored Energy		89				
E _{ON}	Turn-On Switching Energy (Body Diode)		1.7		mJ	V _{DS} = 800 V, V _{GS} = -5/20 V I _D = 40A, R _{G(ext)} = 2.5Ω, L = 99 μH	Fig. 25
E _{OFF}	Turn Off Switching Energy (Body Diode)		0.4				
E _{ON}	Turn-On Switching Energy (External SiC Diode)		1.3				
E _{OFF}	Turn Off Switching Energy (External SiC Diode)		0.4				
t _{d(on)}	Turn-On Delay Time		13		ns	V _{DD} = 800 V, V _{GS} = -5/20 V I _D = 40 A R _{G(ext)} = 2.5 Ω, R _L = 20 Ω Timing relative to V _{DS} Per IEC60747-8-4 pg 83	Fig. 27
t _r	Rise Time		61				
t _{d(off)}	Turn-Off Delay Time		25				
t _f	Fall Time		13				
R _{G(int)}	Internal Gate Resistance		1.8		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q _{gs}	Gate to Source Charge		34		nC	V _{DS} = 800 V, V _{GS} = -5/20 V I _D = 40 A Per IEC60747-8-4 pg 21	Fig. 12
Q _{gd}	Gate to Drain Charge		42				
Q _g	Total Gate Charge		120				

**MDDG1C120R040K3**

1200V N-Channel SiC Power MOSFET

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.0		V	$V_{GS} = -5\text{ V}, I_{SD} = 20\text{ A}, T_J = 25^\circ\text{C}$	Fig. 8, 9, 10
		3.6		V	$V_{GS} = -5\text{ V}, I_{SD} = 20\text{ A}, T_J = 150^\circ\text{C}$	
I_S	Continuous Diode Forward Current		60	A	$T_c = 25^\circ\text{C}$	Note 1
$I_{S,pulse}$	Diode Pulse Current		160	A	$V_{GS} = -5\text{ V},$ Pulse width t_P limited by T_{jmax}	
t_{rr}	Reverse Recovery Time	54		ns	$V_{GS} = -5\text{ V}, I_{SD} = 40\text{ A} T_J = 25^\circ\text{C}$ $VR = 800\text{ V}$ $dif/dt = 1000\text{ A}/\mu\text{s}$	Note 1
Q_{rr}	Reverse Recovery Charge	283		nC		
I_{rm}	Peak Reverse Recovery Current	15		A		

Note (1): When using SiC Body Diode the maximum recommended $V_{GS} = -5\text{V}$

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
R_{iJC}	Thermal Resistance from Junction to Case	0.33	0.45	°C/W		Fig. 21
R_{iJA}	Thermal Resistance from Junction to Ambient		40			

Typical Performance

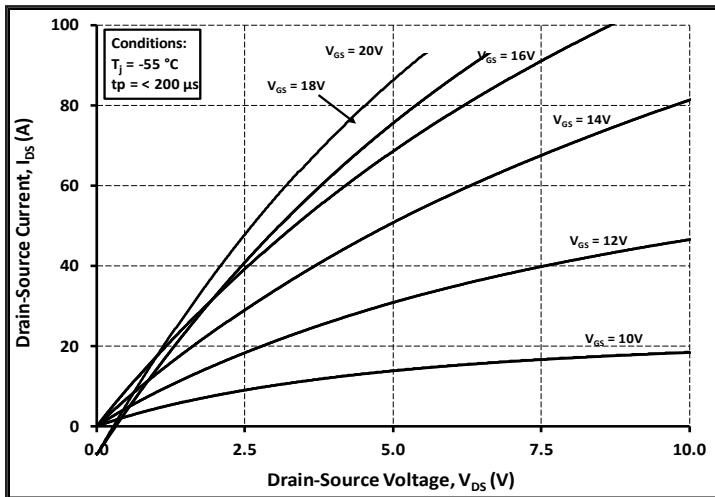


Figure 1. Output Characteristics $T_j = -55^\circ\text{C}$

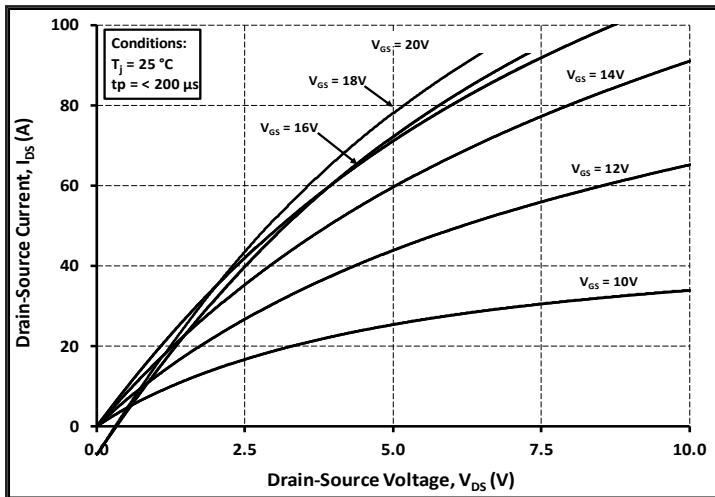


Figure 2. Output Characteristics $T_j = 25^\circ\text{C}$

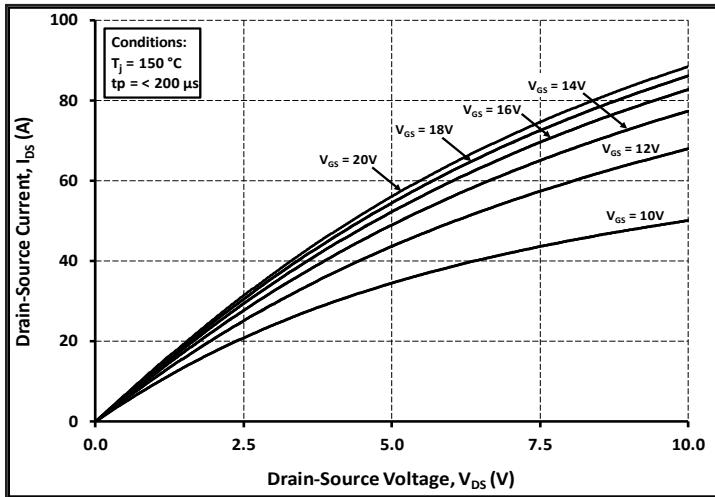


Figure 3. Output Characteristics $T_j = 150^\circ\text{C}$

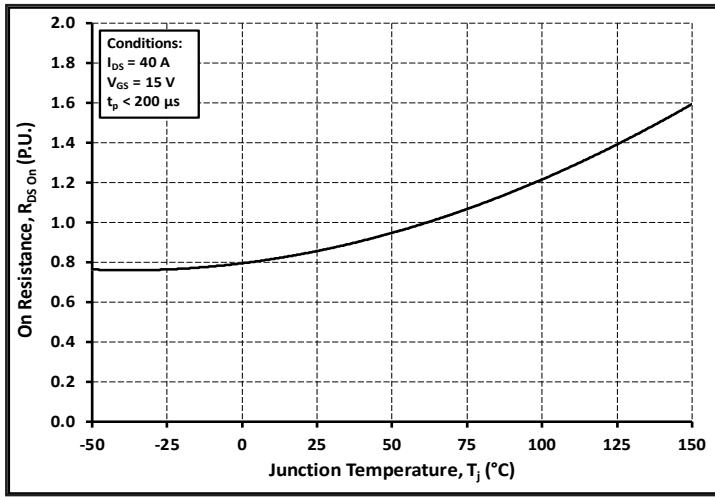


Figure 4. Normalized On-Resistance vs. Temperature

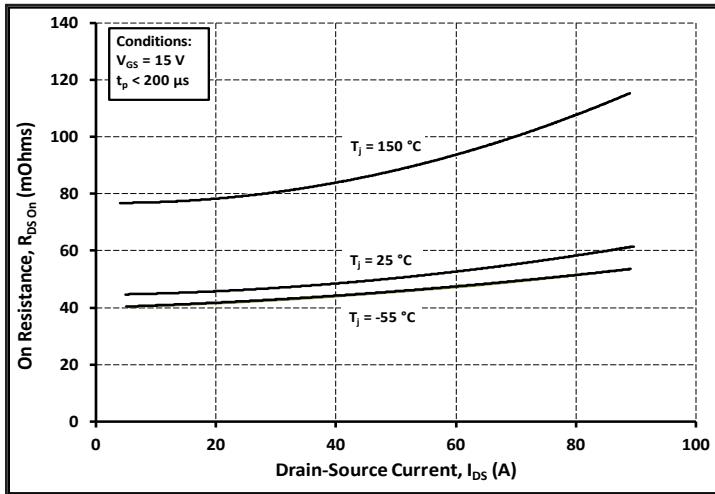


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

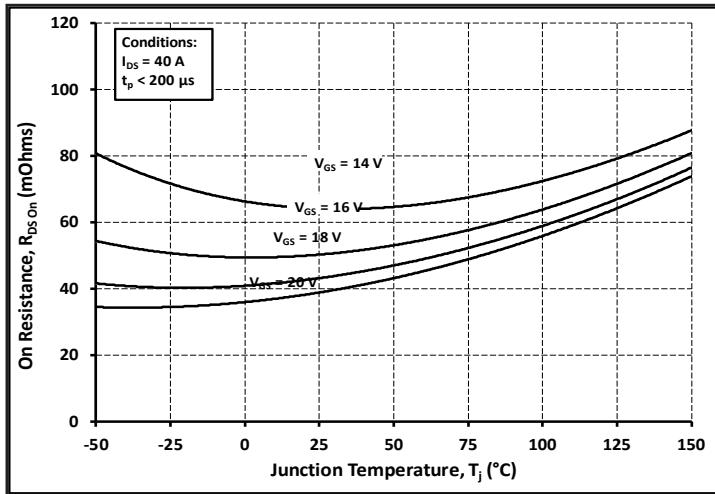


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

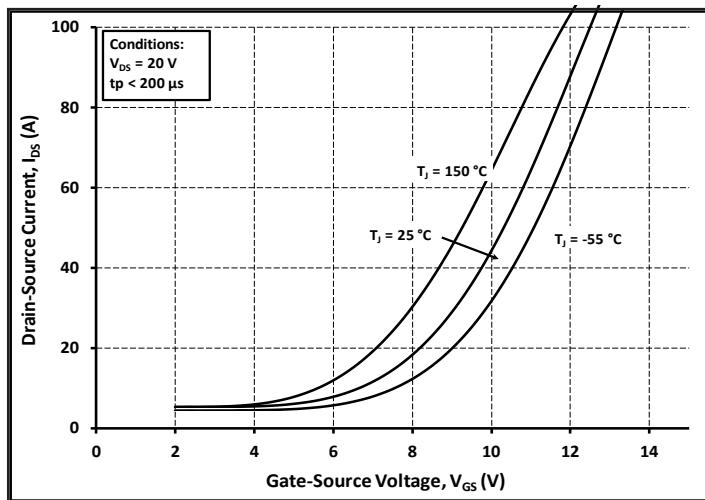


Figure 7. Transfer Characteristic for Various Junction Temperatures

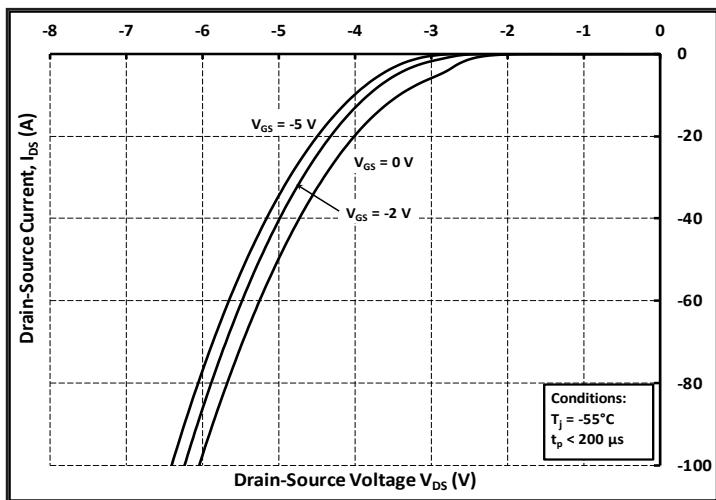


Figure 8. Body Diode Characteristic at -55°C

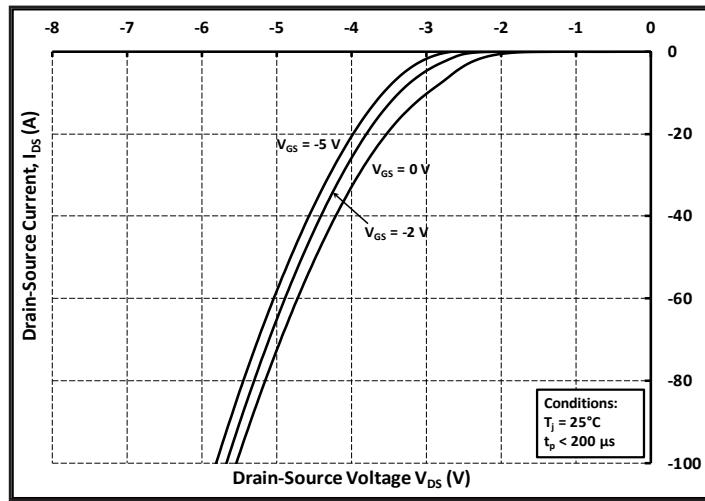


Figure 9. Body Diode Characteristic at 25°C

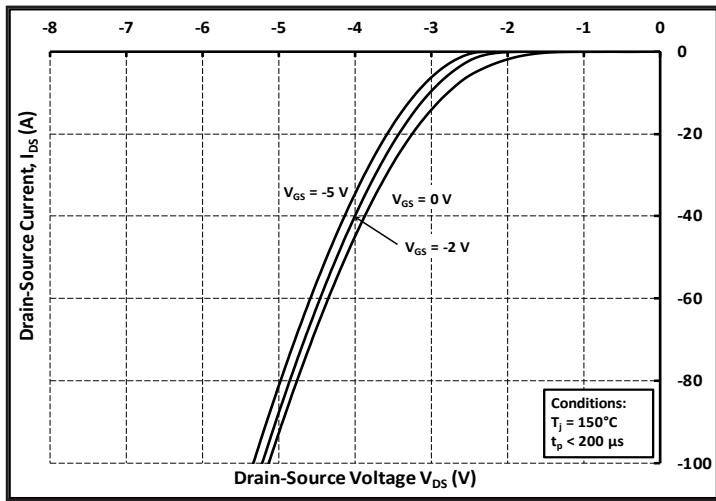


Figure 10. Body Diode Characteristic at 150°C

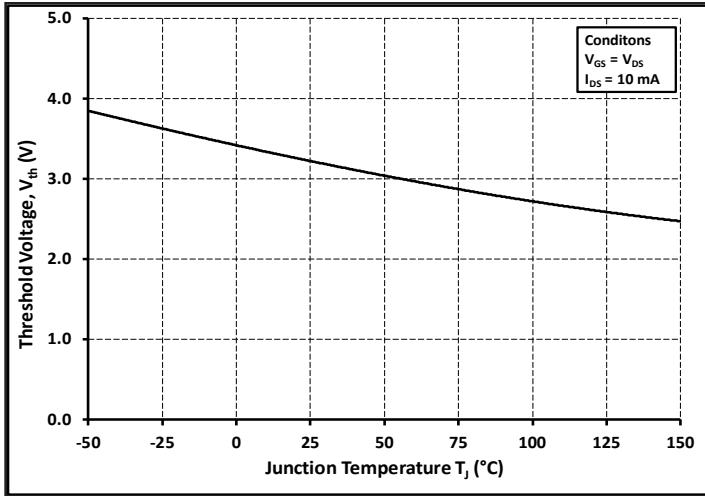


Figure 11. Threshold Voltage vs. Temperature

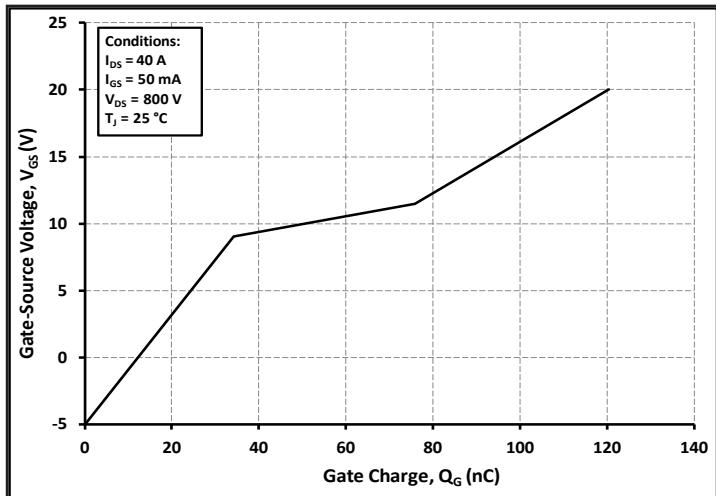


Figure 12. Gate Charge Characteristics

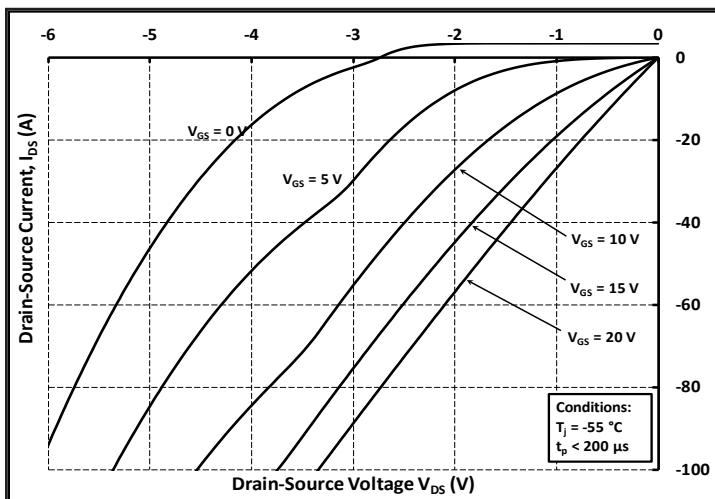
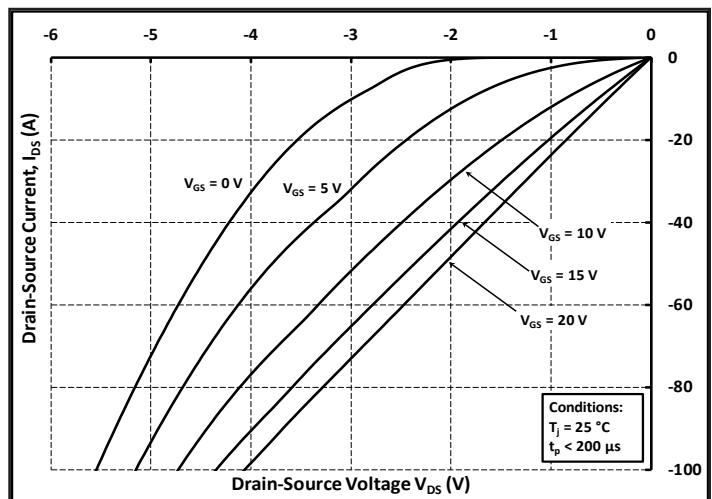
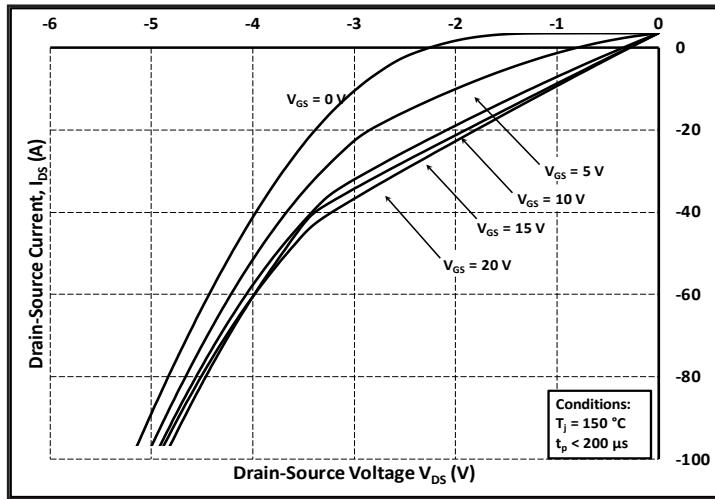
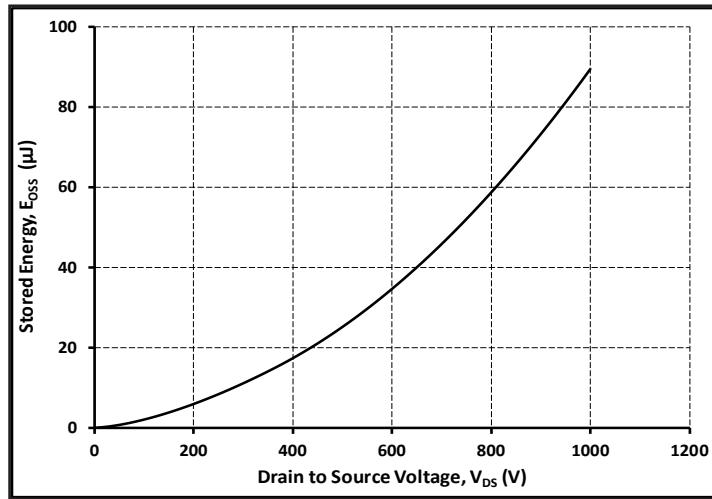

 Figure 13. 3rd Quadrant Characteristic at $-55\text{ }^{\circ}\text{C}$

 Figure 14. 3rd Quadrant Characteristic at $25\text{ }^{\circ}\text{C}$

 Figure 15. 3rd Quadrant Characteristic at $150\text{ }^{\circ}\text{C}$


Figure 16. Output Capacitor Stored Energy

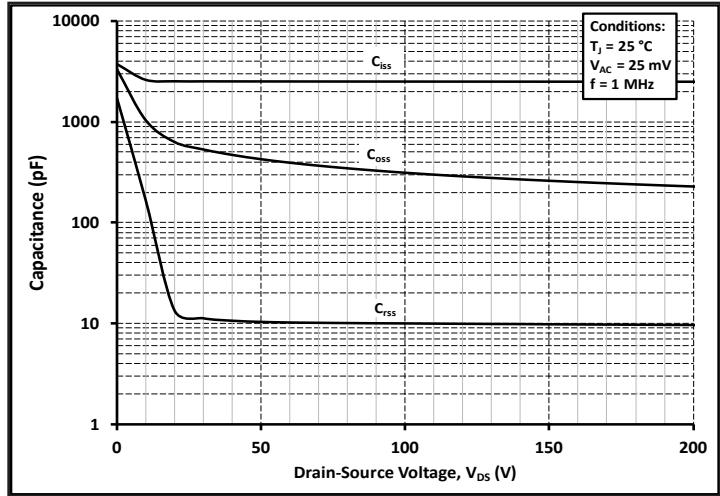


Figure 17. Capacitances vs. Drain-Source Voltage (0-200 V)

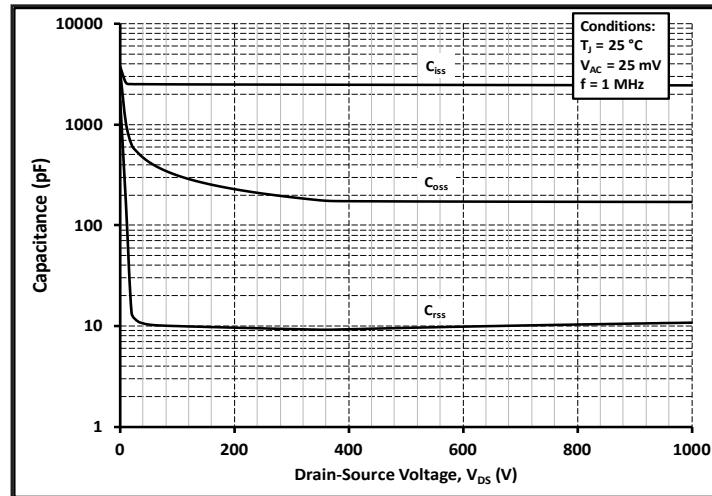


Figure 18. Capacitances vs. Drain-Source Voltage (0-1000 V)

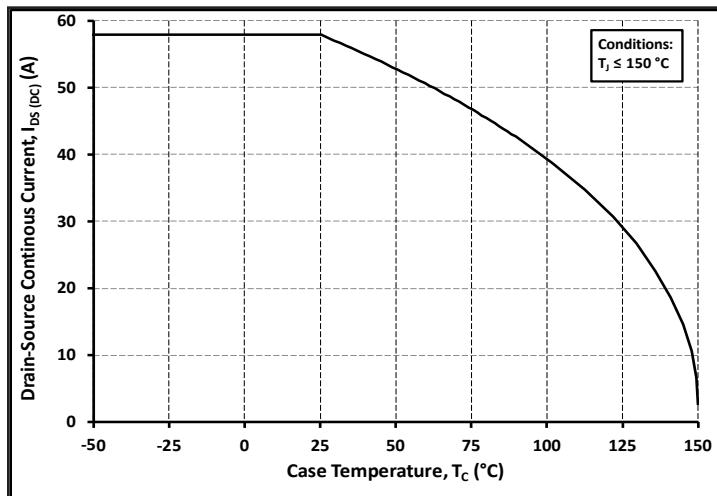


Figure 19. Continuous Drain Current Derating vs.
Case Temperature

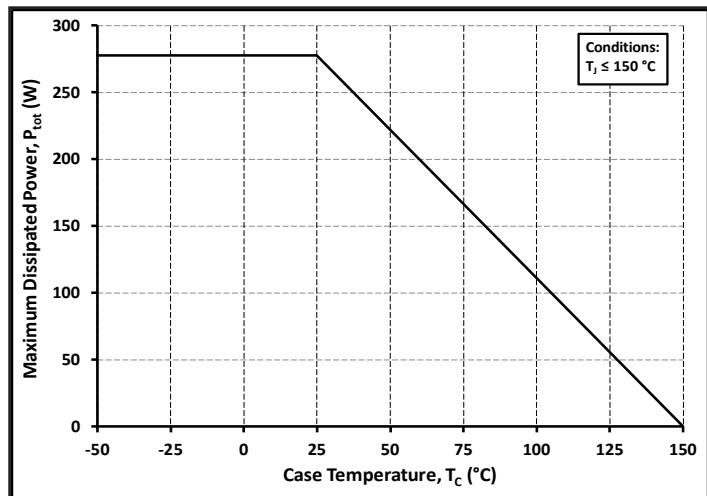


Figure 20. Maximum Power Dissipation Derating vs.
Case Temperature

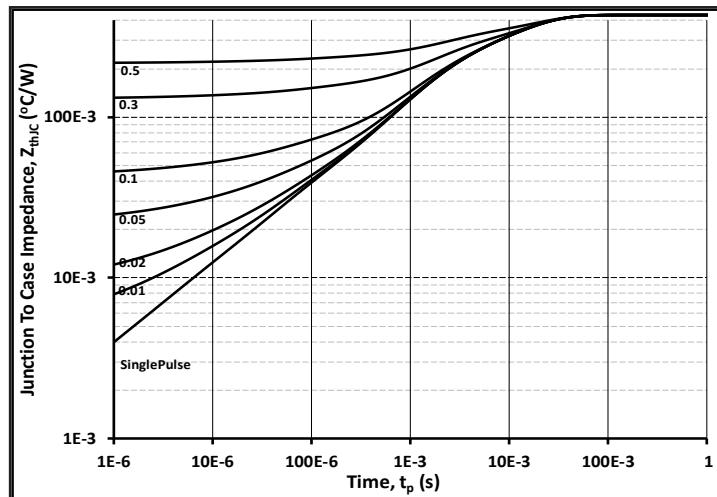


Figure 21. Transient Thermal Impedance
(Junction - Case)

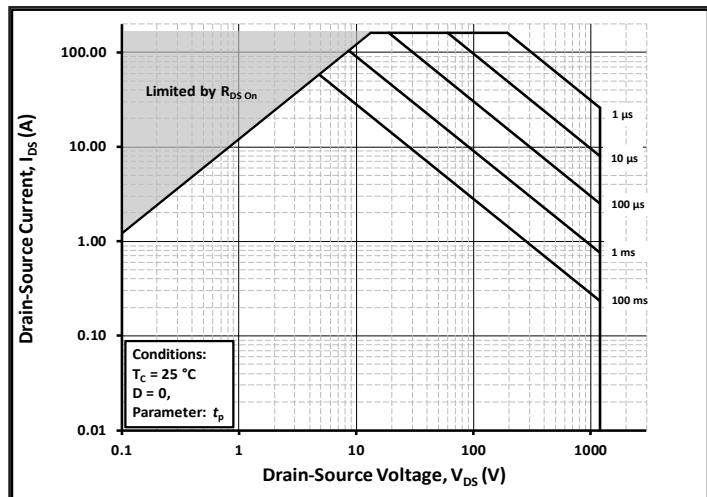


Figure 22. Safe Operating Area

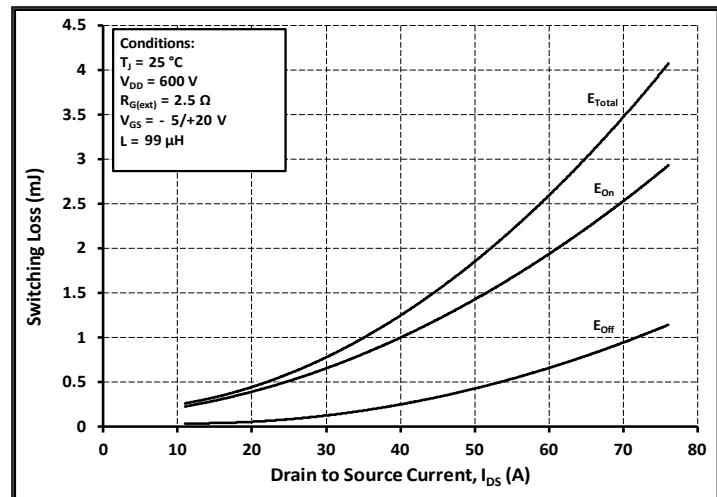


Figure 23. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD} = 600V$)

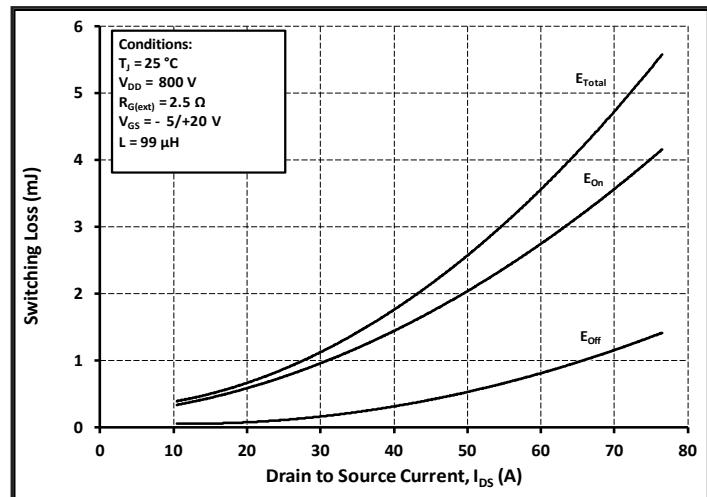


Figure 24. Clamped Inductive Switching Energy vs.
Drain Current ($V_{DD} = 800V$)

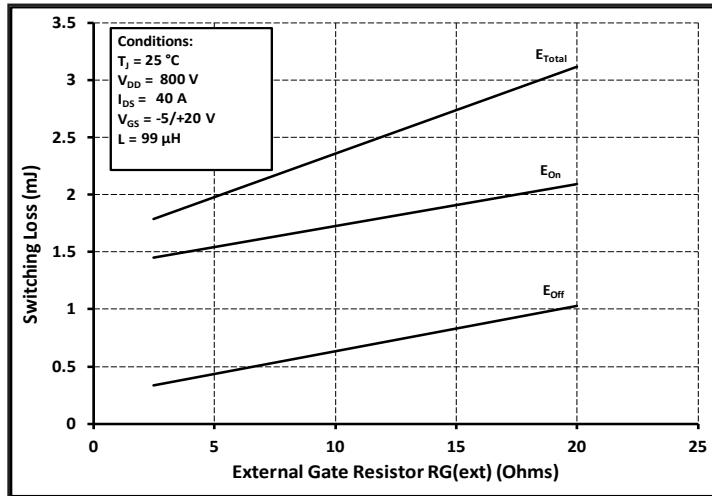
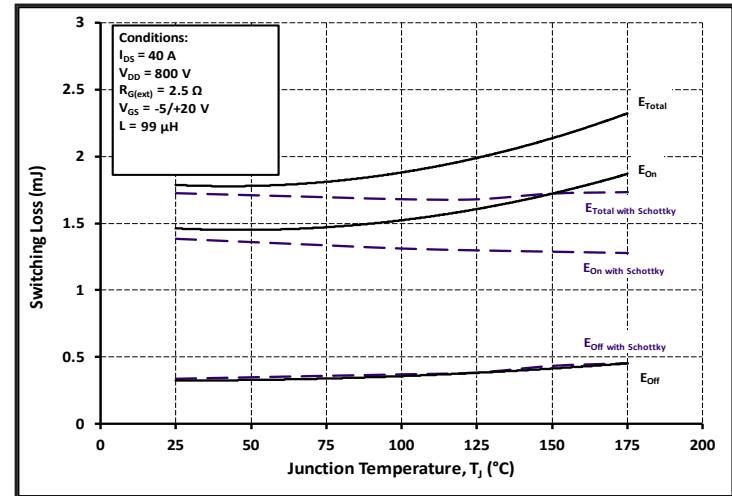

 Figure 25. Clamped Inductive Switching Energy vs. $R_{G(\text{ext})}$


Figure 26. Clamped Inductive Switching Energy vs. Temperature

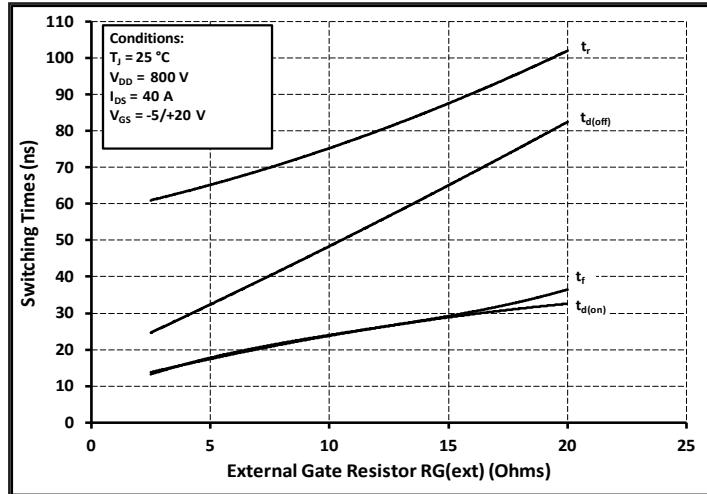
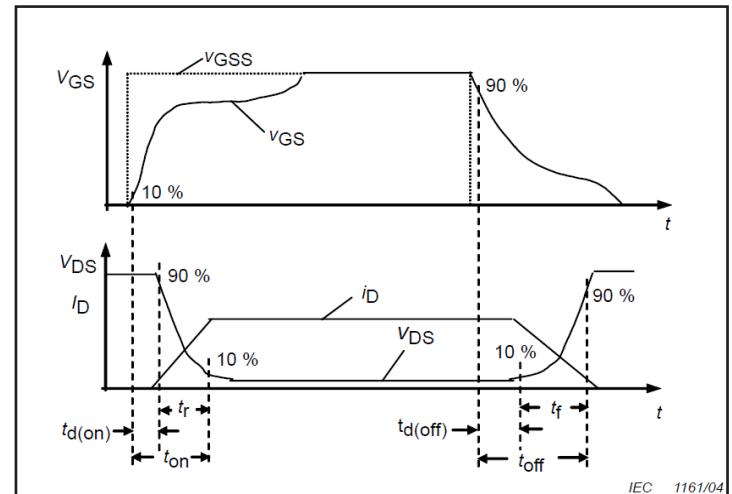

 Figure 27. Switching Times vs. $R_{G(\text{ext})}$


Figure 28. Switching Times Definition

Test Circuit Schematic

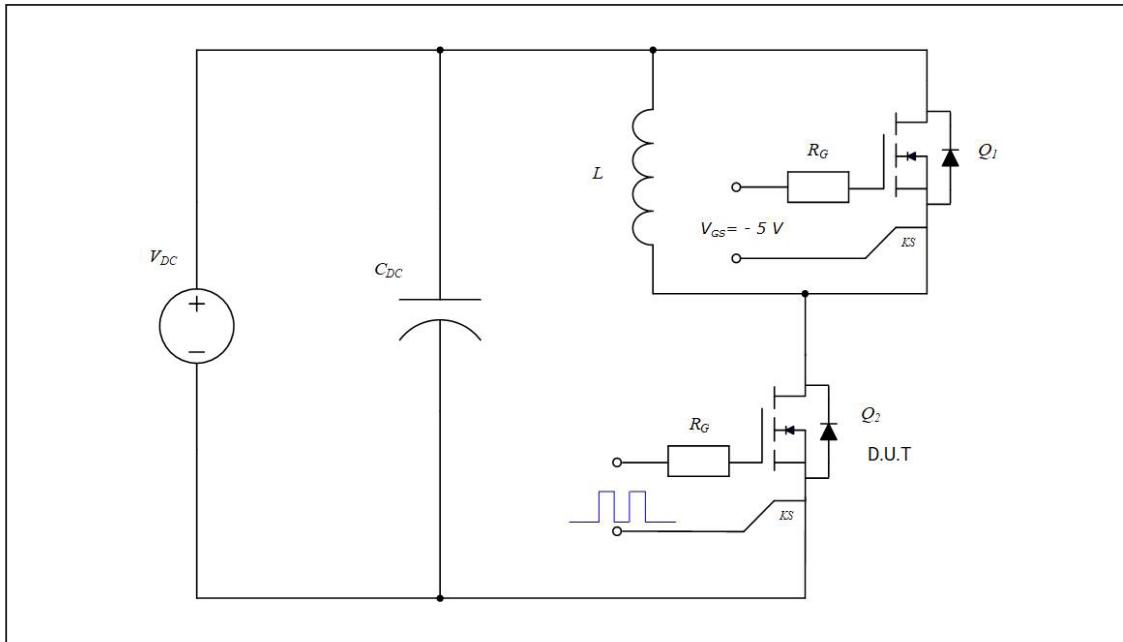


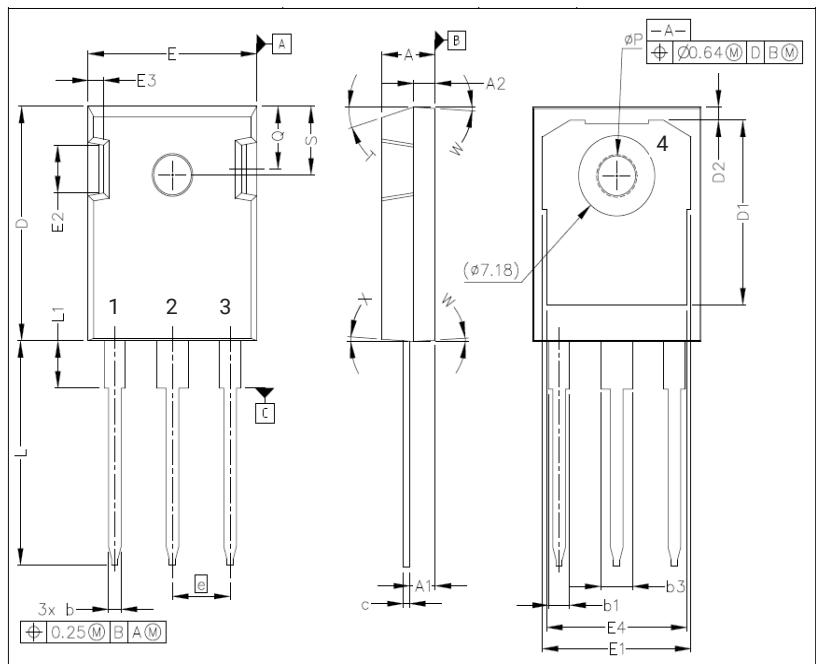
Figure 29. Clamped Inductive Switching Waveform Test Circuit

ESD Ratings

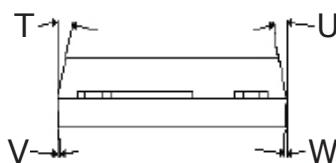
ESD Test	Resulting Classification
ESD-HBM	3A (4000V - 8000V)
ESD-CDM	C3 ($\geq 1000V$)

Package Dimensions

Package TO-247-3



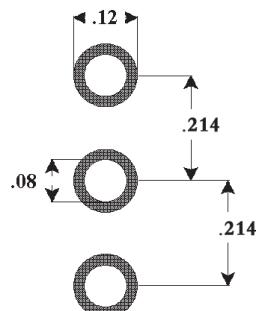
SYM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	.190	.205
A1	2.29	2.54	.090	.100
A2	1.91	2.16	.075	.085
b	1.07	1.33	.042	.052
b1	1.91	2.41	.075	.095
b3	2.87	3.38	.113	.133
c	0.55	0.68	.022	.027
D	20.80	21.10	.819	.831
D1	16.25	17.65	.640	.695
D2	0.95	1.25	.037	.049
E	15.75	16.13	.620	.635
E1	13.10	14.15	.516	.557
E2	3.68	5.10	.145	.201
E3	1.00	1.90	.039	.075
E4	12.38	13.43	.487	.529
e	5.44 BSC		.214 BSC	
N	3		3	
L	19.81	20.32	.780	.800
L1	4.10	4.40	.161	.173
øP	3.51	3.65	.138	.144
Q	5.49	6.00	.216	.236
S	6.04	6.30	.238	.248
T	17.5° REF.			
W	3.5° REF.			
X	4° REF.			



Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

Recommended Solder Pad Layout



TO-247-3